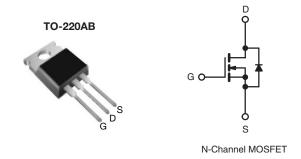


### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	400			
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V 0.55			
Q <sub>g</sub> (Max.) (nC)	36			
Q <sub>gs</sub> (nC)	9.9			
Q <sub>gd</sub> (nC)	16			
Configuration	Single			



### **FEATURES**

• Low Gate Charge Qq Results in Simple Drive



- Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

### **TYPICAL SMPS TOPOLOGIES**

- Single Transistor Flyback Xfmr. Reset
- Single Transistor Forward Xfmr. Reset (Both for US Line Input Only)

ORDERING INFORMATION		
Package	TO-220AB	
Lead (Pb)-free	IRF740APbF	
Lead (FD)-life	SiHF740A-E3	
SnPb	IRF740A	
SIFD	SiHF740A	

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	400		
Gate-Source Voltage			$V_{GS}$	± 30	V	
Continuous Drain Current	\/ at 10.\/	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		10		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	6.3	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	40		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	630	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	10	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	12.5	mJ	
Maximum Power Dissipation T <sub>C</sub> = 25 °C			$P_{D}$	125	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.9	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s			300 <sup>d</sup>	7		
Mounting Torque	6 22 or l	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 OF IVIS SCIEW			1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 12.6 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 10 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 10 \text{ A}$ ,  $dV/dt \le 330 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150 \text{ °C}$ .

- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.0		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	V, I <sub>D</sub> = 250 μA	400	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I <sub>D</sub> = 1 mA	-	0.48	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_0$	<sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	<sub>S</sub> = ± 30 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	,	$V_{DS} = 40$	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Gurrent	I <sub>DSS</sub>	$V_{DS} = 320 \text{ V}, \text{ V}$	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 6.0 \text{ A}^b$	-	-	0.55	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 50	0 V, I <sub>D</sub> = 6.0 A <sup>b</sup>	4.9	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V	<sub>GS</sub> = 0 V,	-	1030	-	
Output Capacitance	C <sub>oss</sub>	V <sub>C</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		170	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 f			7.7	-	
Output Capacitance	Coss	$V_{GS} = 0 \text{ V}, V_{DS} = 1.0 \text{ V}, f = 1.0 \text{ MHz}$ $V_{GS} = 0 \text{ V}, V_{DS} = 320 \text{ V}, f = 1.0 \text{ MHz}$		-	1490	-	
Output Capacitance	Ooss			-	52	-	
Effective Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, \	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 V to 320 V		61	-	
Total Gate Charge	$Q_g$	V <sub>GS</sub> = 10 V		-	-	36	nC
Gate-Source Charge	$Q_{gs}$			-	-	9.9	
Gate-Drain Charge	$Q_{gd}$		See lig. 6 and 15		-	16	
Turn-On Delay Time	$t_{d(on)}$			-	10	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 20	$V_{DD}$ = 200 V, $I_{D}$ = 10 A, $R_{g}$ = 10 Ω, $R_{D}$ = 19.5 Ω, see fig. 10 <sup>b</sup>		35	-	ns
Turn-Off Delay Time	$t_{d(off)}$				24	-	- 115
Fall Time	t <sub>f</sub>	1		-	22	-	
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	40	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	2.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = 10 A, dl/dt = 100 A/μs <sup>b</sup>		-	240	360	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	1.9	2.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

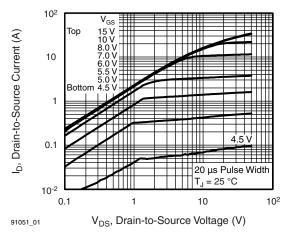


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

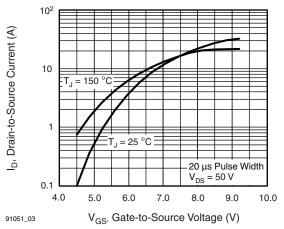


Fig. 3 - Typical Transfer Characteristics

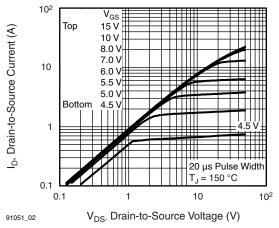


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

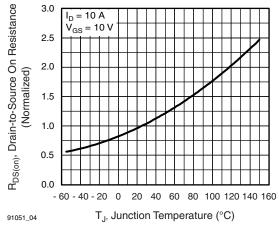


Fig. 4 - Normalized On-Resistance vs. Temperature



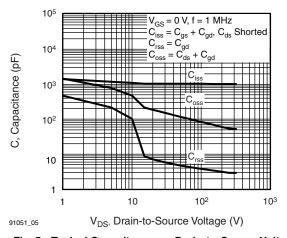


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

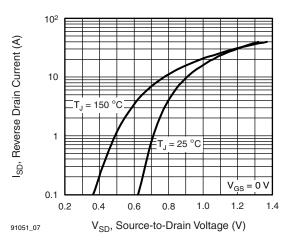


Fig. 7 - Typical Source-Drain Diode Forward Voltage

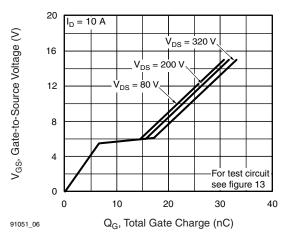


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

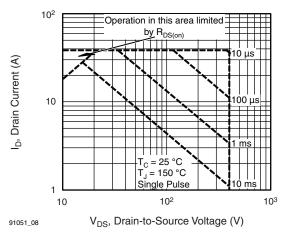


Fig. 8 - Maximum Safe Operating Area





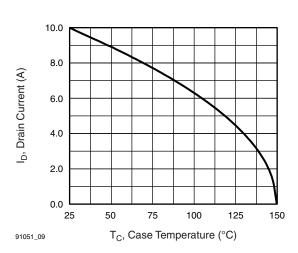


Fig. 9 - Maximum Drain Current vs. Case Temperature

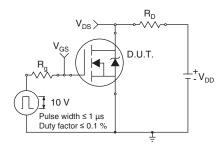


Fig. 10a - Switching Time Test Circuit

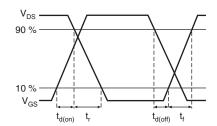


Fig. 10b - Switching Time Waveforms

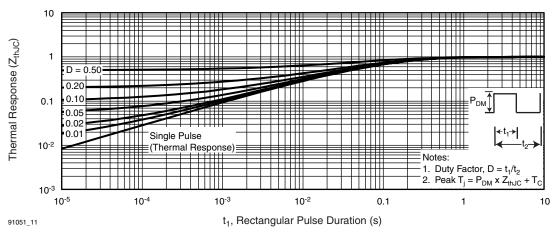


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

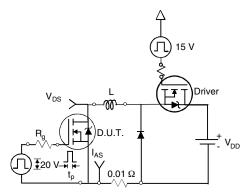


Fig. 12a - Unclamped Inductive Test Circuit

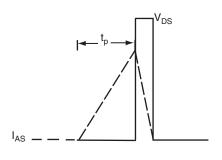


Fig. 12b - Unclamped Inductive Waveforms



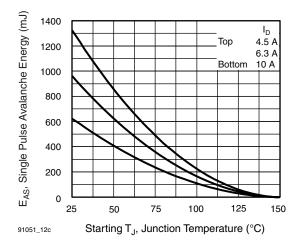


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

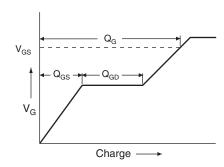


Fig. 13a - Basic Gate Charge Waveform

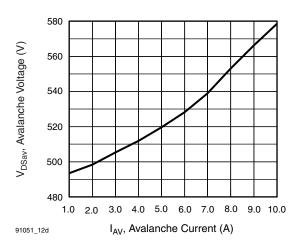


Fig. 12d - Typical Drain-to-Source Voltage vs. Avalanche Current

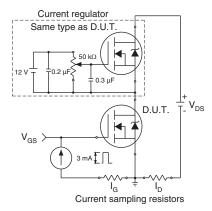
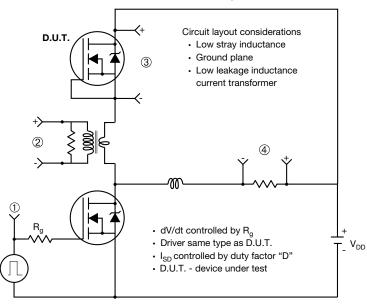


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



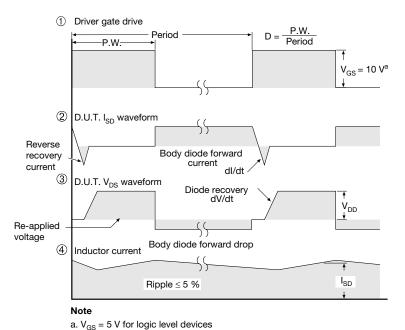


Fig. 14 - For N-Channel

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# **TO-220AB**



	D2

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
D2	12.19	12.70	0.480	0.500
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: T14-0413-Rev. P, 16-Jun-14 DWG: 5471				

#### Note

 $<sup>^{\</sup>star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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Revision: 02-Oct-12 Document Number: 91000